

# IRF7524D1PbF

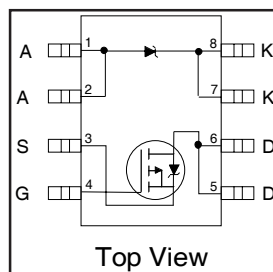
## FETKY™ MOSFET & Schottky Diode

- Co-packaged HEXFET® Power MOSFET and Schottky Diode
- P-Channel HEXFET
- Low  $V_F$  Schottky Rectifier
- Generation 5 Technology
- Micro8™ Footprint
- Lead-Free

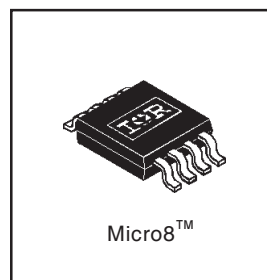
### Description

The **FETKY™** family of co-packaged HEXFETs and Schottky diodes offer the designer an innovative board space saving solution for switching regulator applications. Generation 5 HEXFETs utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. Combining this technology with International Rectifier's low forward drop Schottky rectifiers results in an extremely efficient device suitable for use in a wide variety of portable electronics applications like cell phone, PDA, etc.

The new Micro8™ package, with half the footprint area of the standard SO-8, provides the smallest footprint available in an SOIC outline. This makes the Micro8™ an ideal device for applications where printed circuit board space is at a premium. The low profile (<1.1mm) of the Micro8™ will allow it to fit easily into extremely thin application environments such as portable electronics and PCMCIA cards.



$V_{DSS} = -20V$
$R_{DS(on)} = 0.27\Omega$
Schottky $V_f = 0.39V$



### Absolute Maximum Ratings

Parameter	Maximum	Units	
$I_D @ T_A = 25^\circ C$	-1.7	A	
$I_D @ T_A = 70^\circ C$	-1.4		
$I_{DM}$	-14		
$P_D @ T_A = 25^\circ C$	1.25	W	
$P_D @ T_A = 70^\circ C$	0.8		
	Linear Derating Factor	10	mW/°C
$V_{GS}$	Gate-to-Source Voltage	$\pm 12$	V
$dv/dt$	Peak Diode Recovery $dv/dt$ ②	-5.0	V/ns
$T_J, T_{STG}$	Junction and Storage Temperature Range	-55 to +150	°C

### Thermal Resistance Ratings

Parameter	Maximum	Units	
$R_{\theta JA}$	Junction-to-Ambient ④	100	°C/W

#### Notes:

- ① Repetitive rating – pulse width limited by max. junction temperature (see Fig. 9)
- ②  $I_{SD} \leq -1.2A$ ,  $di/dt \leq 100A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ C$
- ③ Pulse width  $\leq 300\mu s$  – duty cycle  $\leq 2\%$
- ④ When mounted on 1 inch square copper board to approximate typical multi-layer PCB thermal resistance

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**MOSFET Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	-20	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance	—	0.17	0.27	Ω	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -1.2A ③
		—	0.28	0.40		V <sub>GS</sub> = -2.7V, I <sub>D</sub> = -0.60A ③
V <sub>GS(th)</sub>	Gate Threshold Voltage	-0.70	—	—	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA
g <sub>fs</sub>	Forward Transconductance	1.3	—	—	S	V <sub>DS</sub> = -10V, I <sub>D</sub> = -0.60A
I <sub>DSS</sub>	Drain-to-Source Leakage Current	—	—	-1.0	μA	V <sub>DS</sub> = -16V, V <sub>GS</sub> = 0V
		—	—	-25		V <sub>DS</sub> = -16V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage	—	—	-100	nA	V <sub>GS</sub> = -12V
	Gate-to-Source Reverse Leakage	—	—	100		V <sub>GS</sub> = 12V
Q <sub>g</sub>	Total Gate Charge	—	5.4	8.2	nC	I <sub>D</sub> = -1.2A
Q <sub>gs</sub>	Gate-to-Source Charge	—	0.96	1.4		V <sub>DS</sub> = -16V
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge	—	2.4	3.6		V <sub>GS</sub> = -4.5V, See Fig. 6 ③
t <sub>d(on)</sub>	Turn-On Delay Time	—	9.1	—	ns	V <sub>DD</sub> = -10V
t <sub>r</sub>	Rise Time	—	35	—		I <sub>D</sub> = -1.2A
t <sub>d(off)</sub>	Turn-Off Delay Time	—	38	—		R <sub>G</sub> = 6.0Ω
t <sub>f</sub>	Fall Time	—	43	—		R <sub>D</sub> = 8.3Ω, ③
C <sub>iss</sub>	Input Capacitance	—	240	—		V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance	—	130	—	pF	V <sub>DS</sub> = -15V
C <sub>rss</sub>	Reverse Transfer Capacitance	—	64	—		f = 1.0MHz, See Fig. 5

**MOSFET Source-Drain Ratings and Characteristics**

	Parameter	Min.	Typ.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	-1.25	A	
I <sub>SM</sub>	Pulsed Source Current (Body Diode)	—	—	-9.6		
V <sub>SD</sub>	Body Diode Forward Voltage	—	—	-1.2	V	T <sub>J</sub> = 25°C, I <sub>S</sub> = -1.2A, V <sub>GS</sub> = 0V
t <sub>rr</sub>	Reverse Recovery Time (Body Diode)	—	52	78	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = -1.2A
Q <sub>rr</sub>	Reverse Recovery Charge	—	63	95	nC	di/dt = 100A/μs ③

**Schottky Diode Maximum Ratings**

	Parameter	Max.	Units	Conditions
I <sub>F(av)</sub>	Max. Average Forward Current	1.9	A	50% Duty Cycle. Rectangular Wave, T <sub>A</sub> = 25°C See Fig.14 T <sub>A</sub> = 70°C
		1.4		
I <sub>SM</sub>	Max. peak one cycle Non-repetitive Surge current	120	A	5μs sine or 3μs Rect. pulse 10ms sine or 6ms Rect. pulse Following any rated load condition & with V <sub>RRM</sub> applied
		11		

**Schottky Diode Electrical Specifications**

	Parameter	Max.	Units	Conditions
V <sub>FM</sub>	Max. Forward voltage drop	0.50	V	I <sub>F</sub> = 1.0A, T <sub>J</sub> = 25°C
		0.62		I <sub>F</sub> = 2.0A, T <sub>J</sub> = 25°C
		0.39		I <sub>F</sub> = 1.0A, T <sub>J</sub> = 125°C
		0.57		I <sub>F</sub> = 2.0A, T <sub>J</sub> = 125°C .
I <sub>RM</sub>	Max. Reverse Leakage current	0.02	mA	V <sub>R</sub> = 20V, T <sub>J</sub> = 25°C
		8		T <sub>J</sub> = 125°C
C <sub>t</sub>	Max. Junction Capacitance	92	pF	V <sub>R</sub> = 5Vdc ( 100kHz to 1 MHz) 25°C
dv/dt	Max. Voltage Rate of Charge	3600	V/ μs	Rated V <sub>R</sub>

(HEXFET is the reg. TM for International Rectifier Power MOSFET's)

Power Mosfet Characteristics

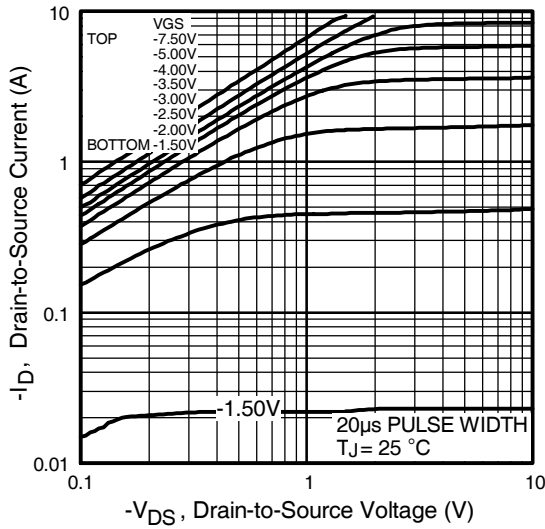


Fig 1. Typical Output Characteristics

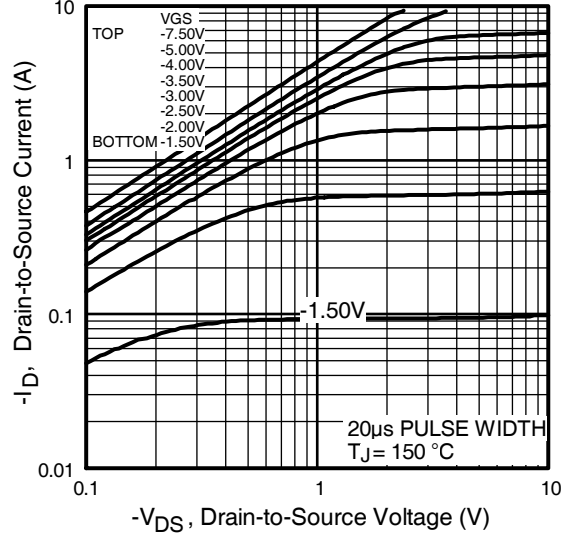


Fig 2. Typical Output Characteristics

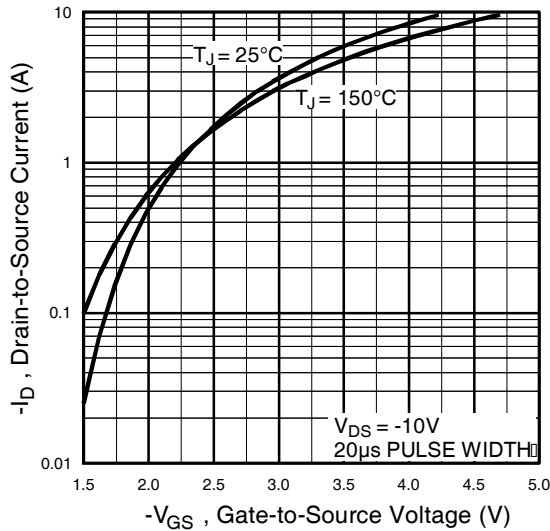


Fig 3. Typical Transfer Characteristics

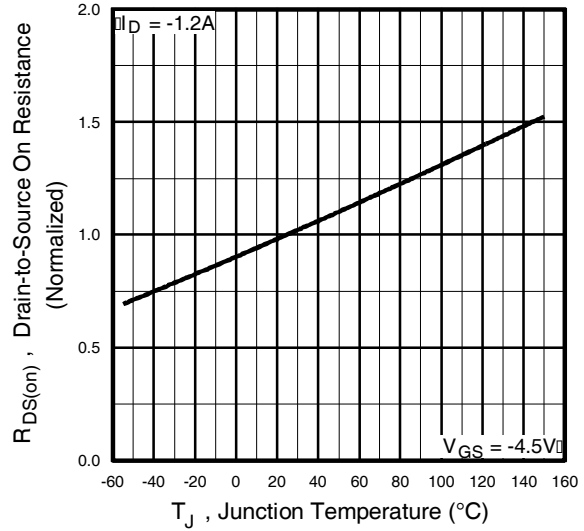


Fig 4. Normalized On-Resistance Vs. Temperature

Power Mosfet Characteristics

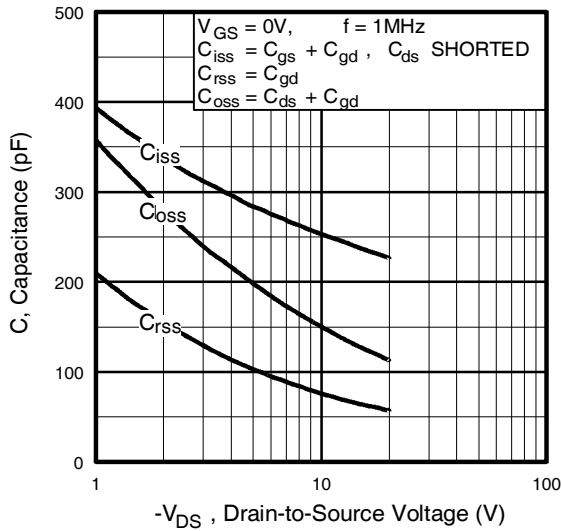


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

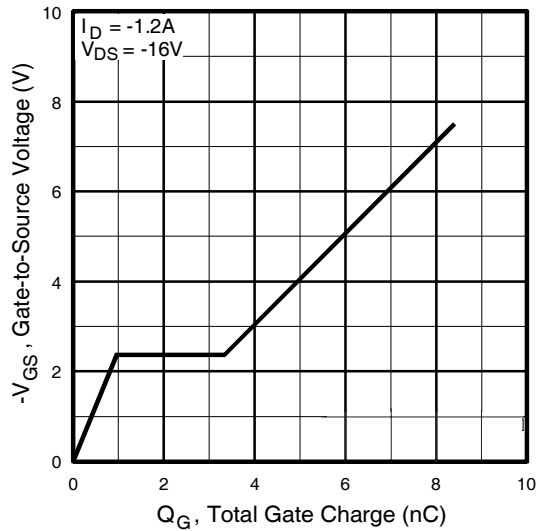


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

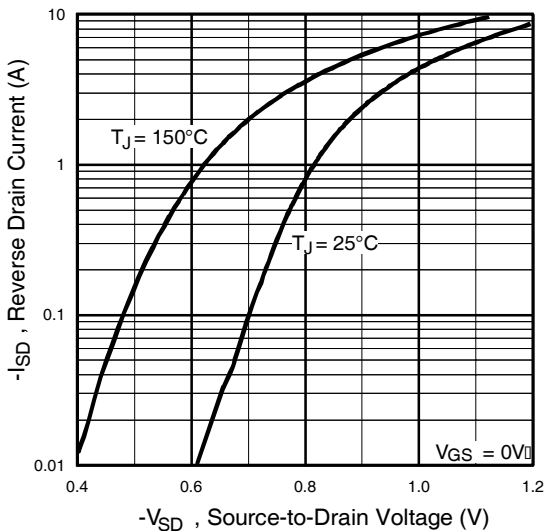


Fig 7. Typical Source-Drain Diode Forward Voltage

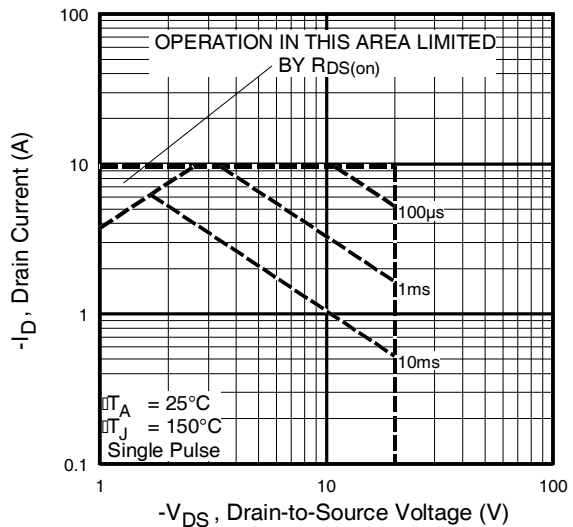


Fig 8. Maximum Safe Operating Area

Power Mosfet Characteristics

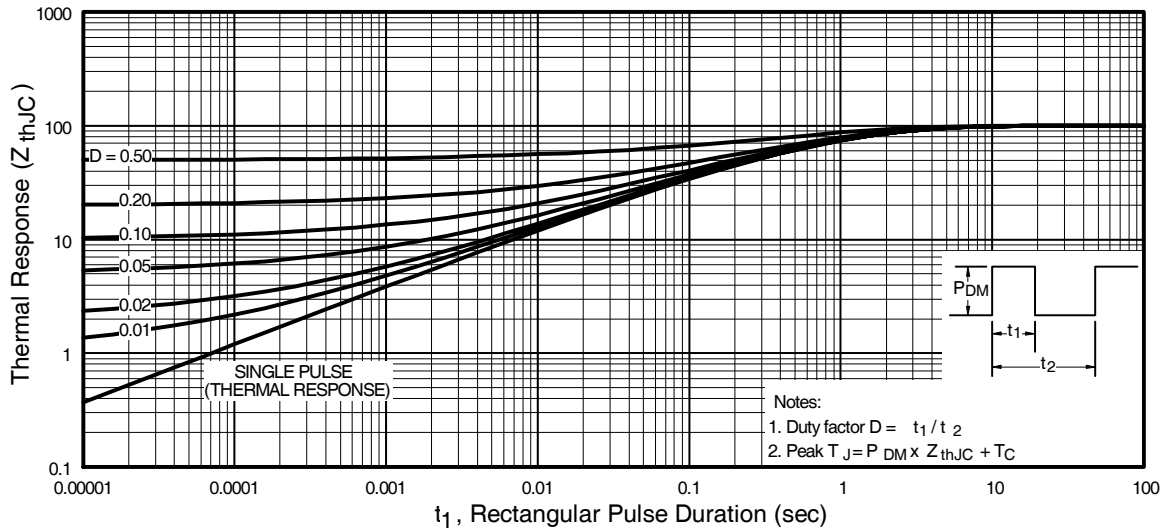


Fig 9. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

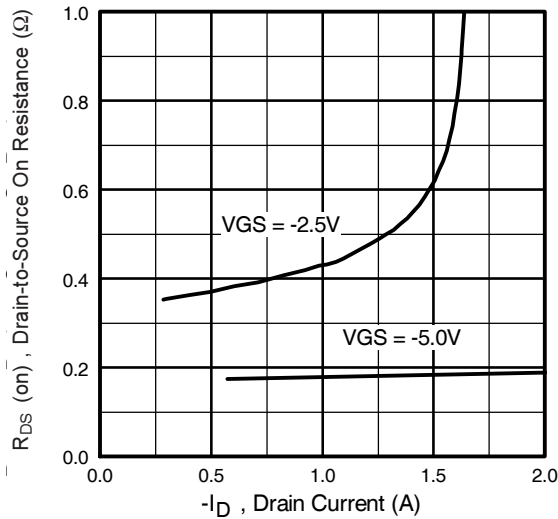


Fig 10. Typical On-Resistance Vs. Drain Current

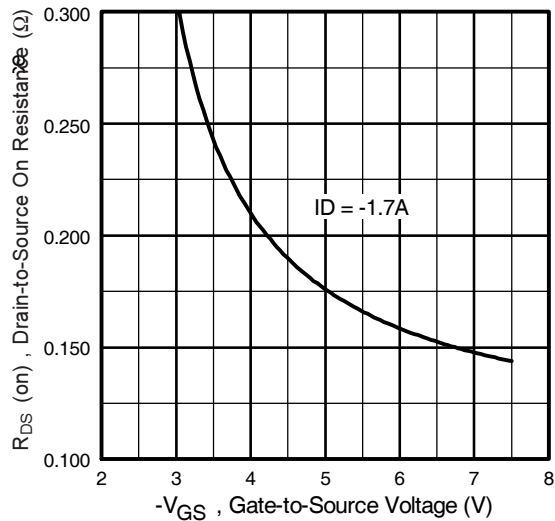
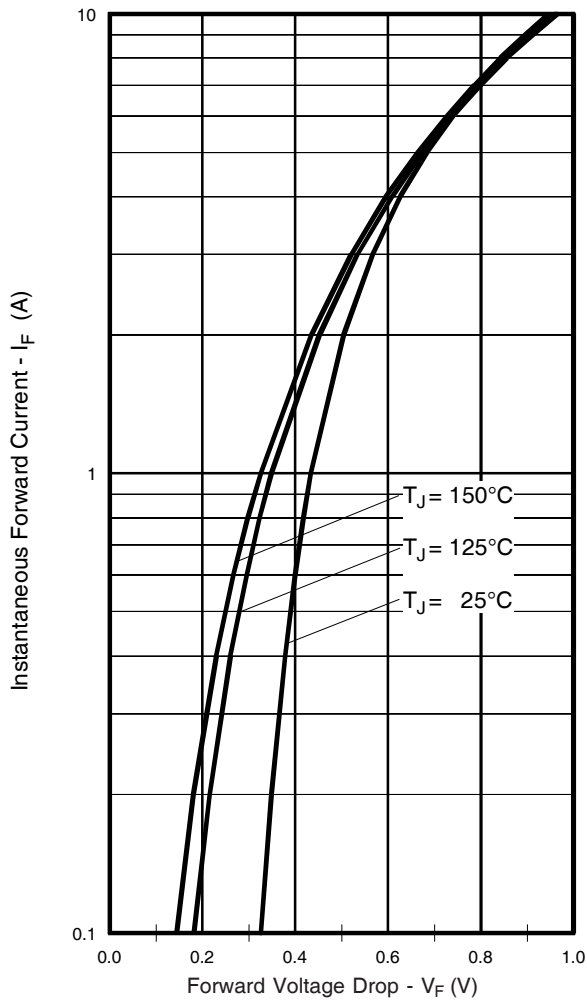
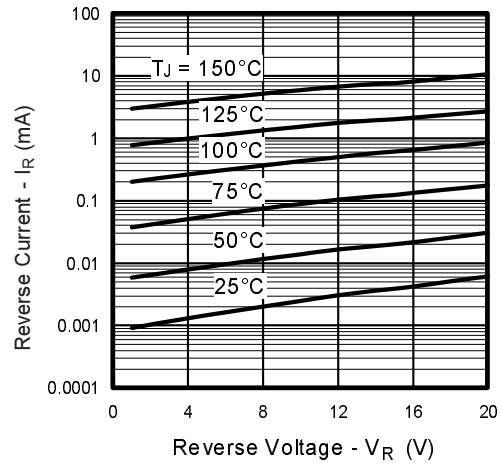


Fig 11. Typical On-Resistance Vs. Gate Voltage

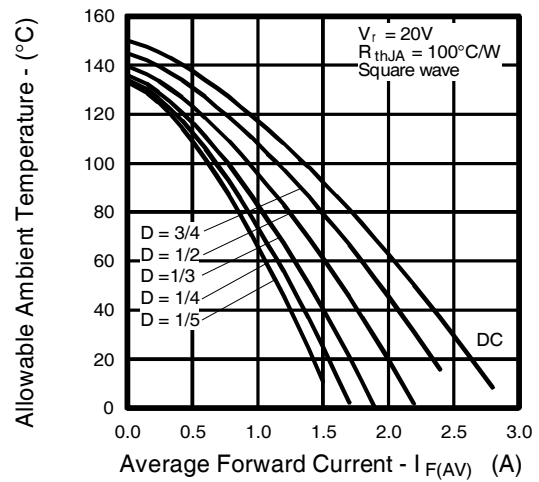
Schottky Diode Characteristics



**Fig. 12** -Typical Forward Voltage Drop Characteristics



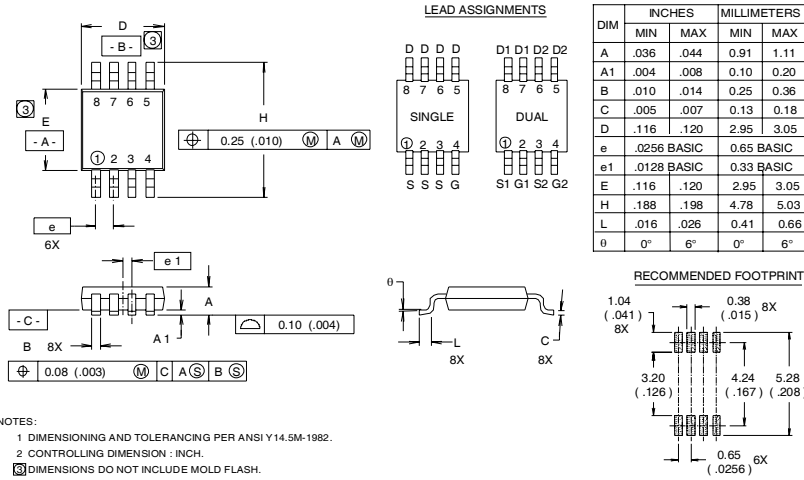
**Fig. 13** - Typical Values of Reverse Current Vs. Reverse Voltage



**Fig.14** - Maximum Allowable Ambient Temp. Vs. Forward Current

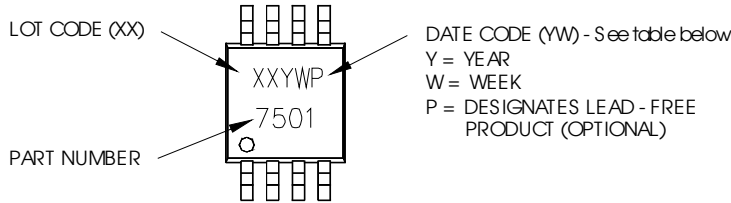
## Micro8 Package Outline

Dimensions are shown in millimeters (inches)



## Micro8 Part Marking Information

EXAMPLE: THIS IS AN IRF7501



WW = (1-26) IF PRECEDED BY LAST DIGIT OF CALENDAR YEAR

YEAR	Y	WORK WEEK	W
2001	1	01	A
2002	2	02	B
2003	3	03	C
2004	4	04	D
2005	5		
2006	6		
2007	7		
2008	8		
2009	9		
2010	0	24	X
		25	Y
		26	Z

WW = (27-52) IF PRECEDED BY A LETTER

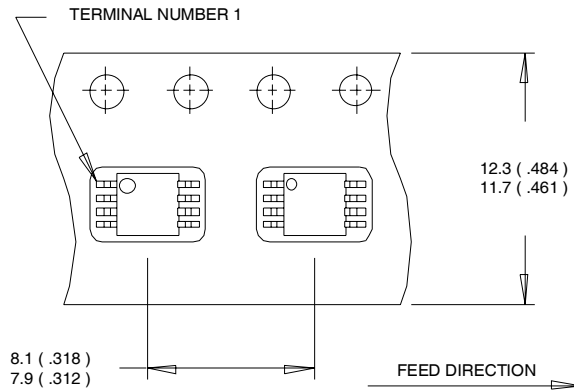
YEAR	Y	WORK WEEK	W
2001	A	27	A
2002	B	28	B
2003	C	29	C
2004	D	30	D
2005	E		
2006	F		
2007	G		
2008	H		
2009	J		
2010	K	50	X
		51	Y
		52	Z

# IRF7524D1PbF

International  
**IR** Rectifier

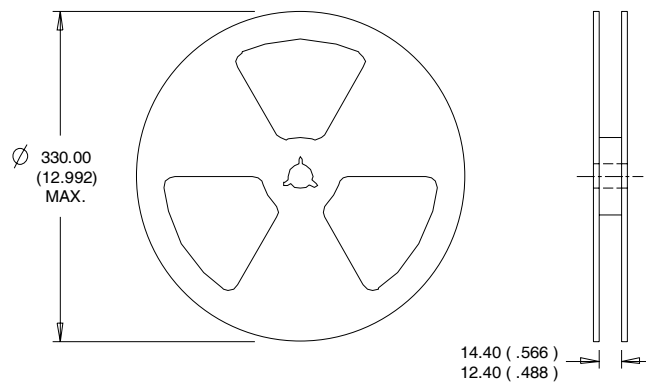
## Micro8 Tape & Reel Information

Dimensions are shown in millimeters (inches)



### NOTES:

1. OUTLINE CONFORMS TO EIA-481 & EIA-541.
2. CONTROLLING DIMENSION : MILLIMETER.



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2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Consumer market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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